



30V N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(on)}	I _D T _A = 25°C		
2014	20mΩ @ V _{GS} = 10V	16.7A		
30V	34mΩ @ V _{GS} = 4.5V	12.6A		

Description and Applications

This new generation MOSFET has been designed to minimize the onstate resistance ($R_{DS(on)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

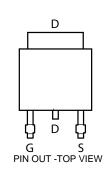
- Backlighting
- DC-DC Converters
- Power management functions

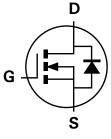
Features and Benefits

- Low on-resistance
- Fast switching speed
- "Green" Component and RoHS compliant

Mechanical Data

- Case: TO252-3L
- Case Material: Molded Plastic "Green" Molding Compound, UL Flammability Classification Rating 94V-0 (Note 1)
- Moisture Sensitivity: Level 1 per J-STD-020D
- Terminal Connections: See Diagram
- Terminals: Matte Tin Finish annealed over Copper leadframe. Solderable per MIL-STD-202, Method 208 🔞
- Marking Information: See Below
- Ordering Information: See Below
- Weight: 0.33 grams (approximate)





Equivalent Circuit

TOP VIEW

Ordering Information (Note 1)

Product	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
DMN3020LK3-13	N3020L	13	16	2,500

Notes: 1. Diodes, Inc. defines "Green" products as those which are Eu RoHS compliant and contain no halogens or antimony compounds; further information about Diodes Inc.'s "Green" Policy can be found on our website. For packaging details, go to our website.

Marking Information



) || = Manufacturer's Marking
N3020L = Product Type Marking Code
YYWW = Date Code Marking
YY = Last two digits of year (ex: 09 = 2009)
WW = Week (01-52)



Maximum Ratings @T_A = 25[°]C unless otherwise specified

Characteristic			Symbol Value		Unit
Drain-Source voltage			V _{DSS}	30	V
Gate-Source voltage			V _{GS} ±20		V
		(Note 3)		16.7	
Continuous Drain current	$V_{GS} = 10V$	T _A =70°C (Note 3)) I _D	13.3	A
		(Note 2)		11.3	
Pulsed Drain current	V _{GS} = 10V	(Note 4)	I _{DM}	51	A
Continuous Source current (Body diode)		(Note 3)	Is	12	A
Pulsed Source current (Body diode)		(Note 4)	I _{SM}	51	A

Thermal Characteristics @TA = 25°C unless otherwise specified

Characteristic		Symbol	Value	Unit	
	(Note 2)		4.1 32.5		
Power dissipation Linear derating factor	(Note 3)	PD	8.9 71.4	₩ mW/°C	
	(Note 5)		2.17 17.4		
Thermal Resistance, Junction to Ambient	(Note 2) (Note 3) (Note 5)	$R_{ ext{ heta}JA}$	30.8 14.0 57.6	°C/W	
Thermal Resistance, Junction to Lead	(Note 6)	R _{θJL}	2.24	°C/W	
Operating and storage temperature range		TJ, T _{STG}	-55 to 150	°C	

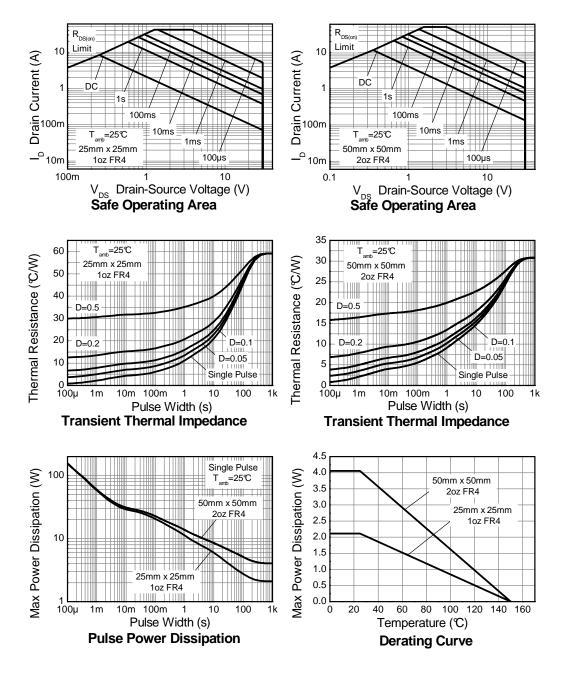
2. For a device surface mounted on 50mm x 50mm x 1.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions; the device is Notes: measured when operating in a steady-state condition.

3. Same as note 2, except the device is measured at t \leq 10 sec. 4. Same as note 2, except the device is pulsed with D = 0.02 and pulse width 300 µs. The pulse current is limited by the maximum junction temperature.

5. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition. 6. Thermal resistance from junction to solder-point (at the end of the drain lead).



Thermal Characteristics





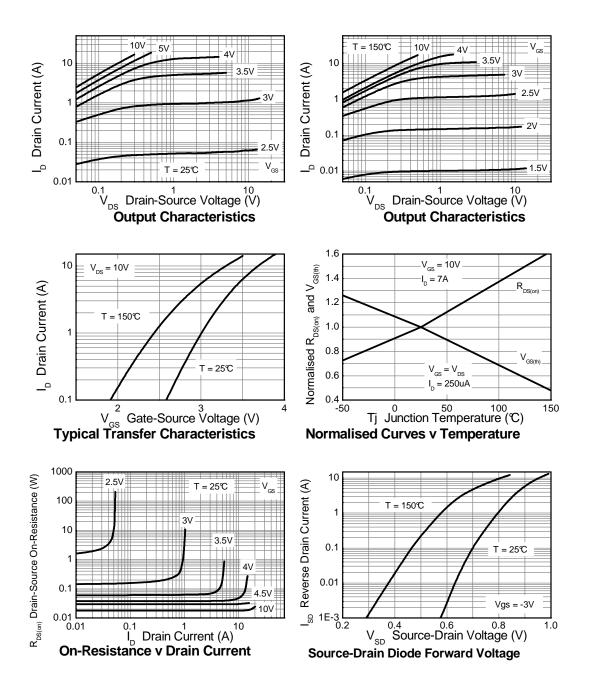
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS			•	•			
Drain-Source Breakdown Voltage	BV _{DSS}	30	_	_	V	$I_D = 250 \mu A, V_{GS} = 0 V$	
Zero Gate Voltage Drain Current	I _{DSS}	_	_	0.5	μΑ	V _{DS} = 30V, V _{GS} = 0V	
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	V _{GS} = ±20V, V _{DS} = 0V	
ON CHARACTERISTICS							
Gate Threshold Voltage	V _{GS(th)}	1.0	_	3.0	V	I _D = 250μA, V _{DS} = V _{GS}	
Static Drain-Source On-Resistance (Note 7)	Р			0.020	Ω	V _{GS} = 10V, I _D = 7.0A	
Static Drain-Source On-Resistance (Note 7)	R _{DS (ON)}	_	_	0.034	12	V _{GS} = 4.5V, I _D = 6.0A	
Forward Transconductance (Notes 7 & 8)	g fs	_	16.5	_	S	V _{DS} = 15V, I _D = 7.1A	
Diode Forward Voltage (Note 7)	V _{SD}	_	0.82	1.2	V	I _S = 1.7A, V _{GS} = 0V	
Reverse recovery time (Note 8)	t _{rr}		12	_	ns		
Reverse recovery charge (Note 8)	Qrr	_	4.8	_	nC	I _S = 2.2A, di/dt= 100A/μs	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	C _{iss}	_	608	_	pF		
Output Capacitance	C _{oss}	_	132	_	pF	V _{DS} = 15V, V _{GS} = 0V f= 1MHz	
Reverse Transfer Capacitance	C _{rss}	_	71	_	pF		
Total Gate Charge	Qg	_	6.3	_	nC	V _{DS} = 15V, V _{GS} = 4.5V I _D = 7A	
Total Gate Charge	Qg	_	12.9	_	nC		
Gate-Source Charge	Q _{gs}	_	2.5		nC	V _{DS} = 15V, V _{GS} = 10V	
Gate-Drain Charge	Q _{gd}		2.5	_	nC	— I _D = 7A	
Turn-On Delay Time (Note 9)	t _{D(on)}		2.9	_	ns		
Turn-On Rise Time (Note 9)	tr		3.3	—	ns	V _{DD} = 15V, V _{GS} = 10V	
Turn-Off Delay Time (Note 9)	t _{D(off)}		16	—	ns	$I_D=1A, R_G \cong 6.0\Omega$	
Turn-Off Fall Time (Note 9)	t _f	_	8	_	ns		

Notes:

Measured under pulsed conditions. Pulse width ≤ 300µs; duty cycle ≤ 2%
For design aid only, not subject to production testing.
Switching characteristics are independent of operating junction temperatures.

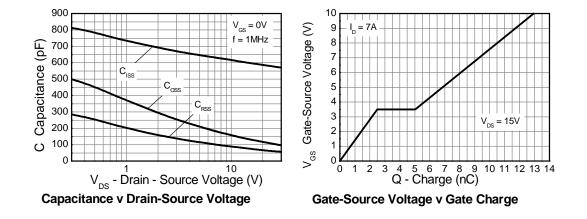


Typical Characteristics

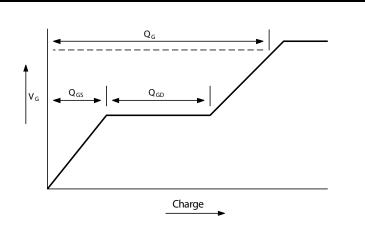




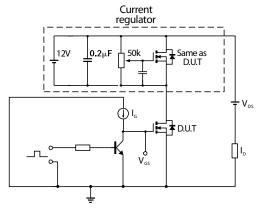
Typical Characteristics - continued



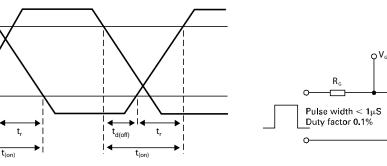
Test Circuits



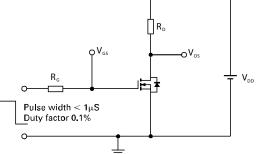
Basic gate charge waveform



Gate charge test circuit



Switching time waveforms



Switching time test circuit

V_{DS} 90%

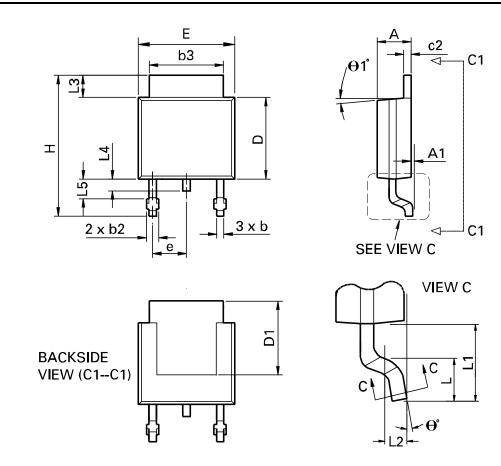
10%

 V_{GS}

t_{d(or}



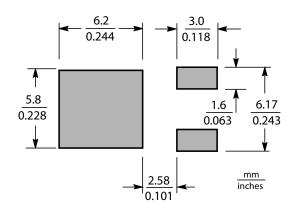
Package Outline Dimensions



DIM	Inc	hes	Millin	neters	DIM	Inches		Millimeters	
	Min	Max	Min	Max		Min	Max	Min	Max
Α	0.086	0.094	2.18	2.39	е	0.090 BSC		2.29 BSC	
A1	-	0.005	-	0.127	н	0.370	0.410	9.40	10.41
b	0.020	0.035	0.508	0.89	L	0.055	0.070	1.40	1.78
b2	0.030	0.045	0.762	1.14	L1	0.108 REF		2.74 REF	
b3	0.205	0.215	5.21	5.46	L2	0.020 BSC		0.508 BSC	
С	0.018	0.024	0.457	0.61	L3	0.035	0.065	0.89	1.65
c2	0.018	0.023	0.457	0.584	L4	0.025	0.040	0.635	1.016
D	0.213	0.245	5.41	6.22	L5	0.045	0.060	1.14	1.52
D1	0.205	-	5.21	-	θ1°	0°	10°	0°	10°
Е	0.250	0.265	6.35	6.73	θ°	0°	15°	0°	15°
E1	0.170	-	4.32	-	-	-	-	-	-



Suggested Pad Layout



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